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FORM P	TO-1449 80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 2007							
LIST OF REFERENCES CITED BY APPLICANT				\ \PPLICANT	APPLICANT: WERNER EBERLE				1 2 200
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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